

STP55N06LFI

N - CHANNEL ENHANCEMENT MODE LOW THRESHOLD POWER MOS TRANSISTOR

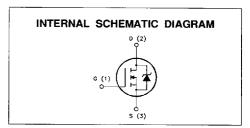
TYPE	V _{DSS}	R _{DS(on)}	lp
STP55N06L	60 V	< 0.023 Ω	55 A
STP55N06LFI	60 V	< 0.023 Ω	30 A

- TYPICAL R_{DS(on)} = 0.02 Ω
- AVALANCHE RUGGED TECHNOLOGY
- 100% AVALANCHC (ESTED
- REPETITIVE AVALANCHE DATA AT 100°C
- LOW GATE CHARGEHIGH CURRENT CAPABILITY
- LOGIC LEVEL COMPATIBLE INPUT
- 175°C OPERATING TEMPERATURE FOR STANDARD PACKAGE
- APPLICATION ORIENTED CHARACTERIZATION

TO-220 ISOWATT220

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- REGULATORS
- DC-DC & DC-AC CONVERTERS
- MOTOR CONTROL, AUDIO AMPLIFIERS
- AUTOMOTIVE ENVIRONMENT (INJECTION, ABS, AIR-BAG, LAMPDRIVERS, Etc.)



ABSOLUTE MAXIMUM RATINGS

		Value	
	STP55N06L	STP55N06LFI	
Drain-source Voltage (V _{GS} = 0)	(60	V
Drain- gate Voltage ($R_{GS} = 20 \text{ k}\Omega$)	6	30	V
Gate-source Voltage	±	15	V
Drain Current (continuous) at T _c = 25 °C	55	30	Α
Drain Current (continuous) at T _c = 100 °C	38	21	Α
Drain Current (pulsed)	220	220	Α
Total Dissipation at T _c = 25 °C	150	45	w
Derating Factor	1	0.3	W/°C
nsulation Withstand Voltage (DC)		2000	V
Storage Temperature	-65 to 175		°C
Max. Operating Junction Temperature	175		°C
	Prain- gate Voltage ($R_{GS} = 20 \text{ k}\Omega$) State-source Voltage Prain Current (continuous) at $T_c = 25 ^{\circ}\text{C}$ Prain Current (continuous) at $T_c = 100 ^{\circ}\text{C}$ Prain Current (pulsed) Fotal Dissipation at $T_c = 25 ^{\circ}\text{C}$ Perating Factor Insulation Withstand Voltage (DC)	$\begin{array}{c} \text{Orain- gate Voltage } (R_{\text{GS}} = 20 \text{ k}\Omega) \\ \text{Gate-source Voltage} \\ \text{Orain Current (continuous) at } T_c = 25 ^{\circ}\text{C} \\ \text{Orain Current (continuous) at } T_c = 100 ^{\circ}\text{C} \\ \text{Orain Current (pulsed)} \\ \text{Orain Current (pulsed)} \\ \text{Otal Dissipation at } T_c = 25 ^{\circ}\text{C} \\ \text{Otal Dissipation at } T_c = 25 ^{\circ}\text{C} \\ \text{Otal Dissipation Withstand Voltage (DC)} \\ \text{Otal Dissipation Withstand Voltage (DC)}$	$\begin{array}{cccccccccccccccccccccccccccccccccccc$

THERMAL DATA

			TO-220	ISOWATT220	
R _{thi-case}	Thermal Resistance Junction-case	Max	1	3.33	°C/W
Rthj-amb	Thermal Resistance Junction-ambient Thermal Resistance Case-sink Maximum Lead Temperature For Soldering F	Max Typ Purpose		62.5 0.5 300	°C/W °C/W °C

AVALANCHE CHARACTERISTICS

Symbol	Parameter	Max Value	Unit
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T_j max, $\delta < 1\%$)	55	Α
Eas	Single Pulse Avalanche Energy (starting T _i = 25 °C, I _D = I _{AR} , V _{DD} = 25 V)	500	mJ
EAR	Repetitive Avalanche Energy (pulse width limited by T_1 max, $\delta < 1\%$)	120	mJ
I _{AR}	Avalanche Current, Repetitive or Not-Repetitive (T _c = 100 °C, pulse width limited by T _i max, δ < 1%)	38	A

ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown Voltage	$I_D = 250 \mu\text{A}$ $V_{GS} = 0$	60			٧
IDSS	Zero Gate Voltage Drain Current (V _{GS} = 0)	V _{DS} = Max Rating V _{DS} = Max Rating x 0.8 T _c = 125 °C		,	250 1000	μ Α μ Α
Igss	Gate-body Leakage Current (V _{DS} = 0)	V _{GS} = ± 15 V			± 100	nA

ON (*)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} I _D = 250 μA	1	1.6	2.5	V
R _{DS(on)}	Static Drain-source On Resistance	$V_{GS} = 5 \text{ V}$ $I_D = 27.5 \text{ A}$ $V_{GS} = 5 \text{ V}$ $I_D = 27.5 \text{ A}$ $T_c = 100^{\circ}\text{C}$		0.02	0.023 0.046	Ω Ω
I _{D(on)}	On State Drain Current	V _{DS} > I _{D(on)} x R _{DS(on)} max V _{GS} = 10 V	55			Α

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g _{fs} (*)	Forward Transconductance	$V_{DS} > I_{D(on)} \times R_{DS(on)max}$ $I_D = 27.5 \text{ A}$	20	39	_	S
C _{iss} C _{oss} C _{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V _{DS} = 25 V f = 1 MHz V _{GS} = 0		2700 850 180	3600 1200 250	pF pF pF

ELECTRICAL CHARACTERISTICS (continued)

SWITCHING ON

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(an)} t _r	Turn-on Time Rise Time	$V_{DD} = 25 \text{ V}$ $I_D = 27.5 \text{ A}$ $R_G = 50 \Omega$ $V_{GS} = 5 \text{ V}$ (see test circuit, figure 3)		150 950	220 1400	ns ns
(di/dt) _{on}	Turn-on Current Slope	$V_{DD} = 40 \text{ V}$ $I_D = 55 \text{ A}$ $R_G = 50 \Omega$ $V_{GS} = 5 \text{ V}$ (see test circuit, figure 5)		110		A/μs
Q _g Q _{gs} Q _{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V _{DD} = 40 V I _D = 55 A V _{GS} = 5 V		55 12 28	80	nC nC nC

SWITCHING OFF

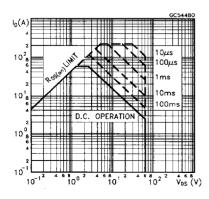
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
tr(Voff)	Off-voltage Rise Time	$V_{DD} = 40 \text{ V}$ $I_D = 55 \text{ A}$	}	185	270	ns
t _c	Cross-over Time	$R_G = 50 \Omega$ $V_{GS} = 5 V$ (see test circuit, figure 5)		250 500	350 700	ns ns

SOURCE DRAIN DIODE

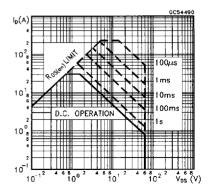
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I _{SD} I _{SDM} (•)	Source-drain Current Source-drain Current (pulsed)				55 220	A A
V _{SD} (*)	Forward On Voltage	I _{SD} = 55 A V _{GS} = 0			1.6	٧
t _{rr}	Reverse Recovery Time	I _{SD} = 55 A di/dt = 100 A/μs V _{DD} = 30 V T _i = 150 °C		120		ns
Q_{rr}	Reverse Recovery Charge	(see test circuit, figure 5)		0.3		μC
IRRM	Reverse Recovery Current			5		Α

^(*) Pulsed: Pulse duration = 300 µs, duty cycle 1.5 %

Safe Operating Areas For TO-220

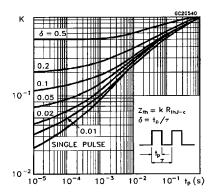


Safe Operating Areas For ISOWATT220

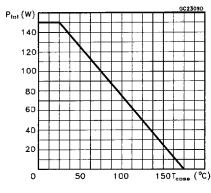


^(•) Pulse width limited by safe operating area

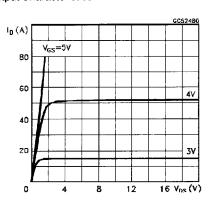
Thermal Impedeance For TO-220



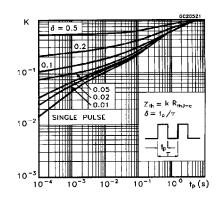
Derating Curve For TO-220



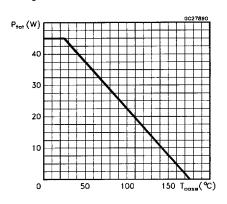
Output Characteristics



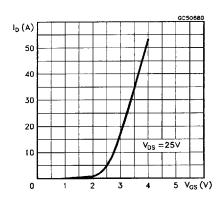
Thermal Impedance For ISOWATT220



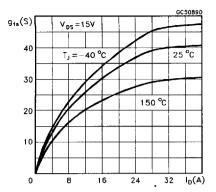
Derating Curve For ISOWATT220



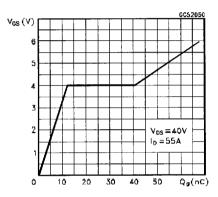
Transfer Characteristics



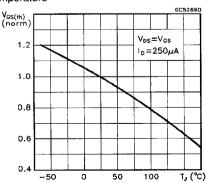
Transconductance



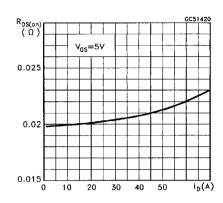
Gate Charge vs Gate-source Voltage



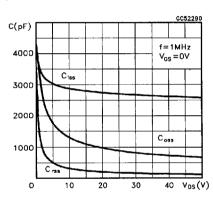
Normalized Gate Threshold Voltage vs Temperature



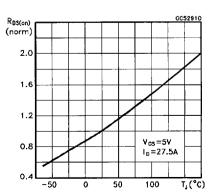
Static Drain-source On Resistance



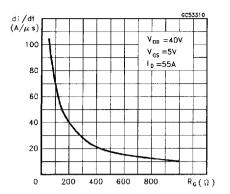
Capacitance Variations



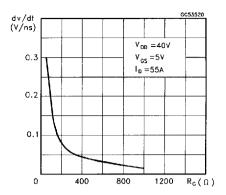
Normalized On Resistance vs Temperature



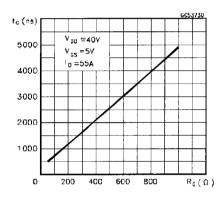
Turn-on Current Slope



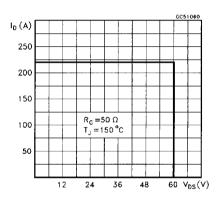
Turn-off Drain-source Voltage Slope



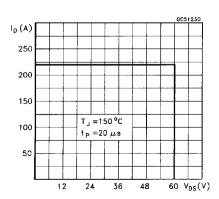
Cross-over Time



Switching Safe Operating Area



Accidental Overload Area



Source-drain Diode Forward Characteristics

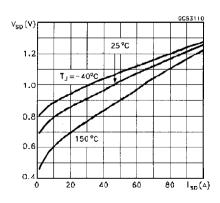


Fig. 1: Unclamped Inductive Load Test Circuits

V₀ ο 2200 3.3 μF V_{DO} μF D.U.T.

Fig. 3: Switching Times Test Circuits For Resistive Load

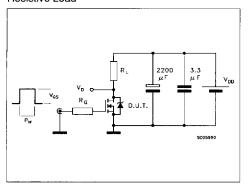


Fig. 5: Test Circuit For Inductive Load Switching And Diode Reverse Recovery Time

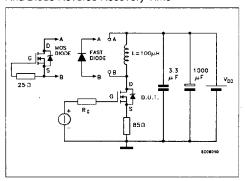


Fig. 2: Unclamped Inductive Waveforms

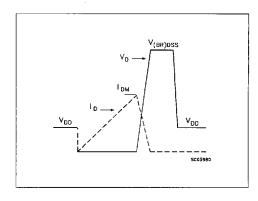


Fig. 4: Gate Charge Test Circuit

